

Notice of References Cited	Application/Control No. 10/568,440		Applicant(s)/Patent Under Reexamination SHIMONISHI ET AL.	
	Examiner Fan Ng		Art Unit 2416	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0080721	06-2002	Tobagi et al.	370/236
*	B	US-6,990,073	01-2006	Sandoval, Jesse	370/232
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	M	US-			

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NON-PATENT DOCUMENTS

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